

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/585,544	MASUMOTO ET AL.	ΓAL.	
Examiner	Art Unit		
Hion D. Vu	2833		

SEARCHED						
Class	Subclass	Date	Examiner			
439	607,564, 567,573,	1/26/2009	ΗV			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR